Product data sheet

1. General description

Planar passivated high commutation three quadrant triac in a IITO220 internally insulated plastic package intended for use in circuits where high static and dynamic dV/dt and high dI/dt can occur. This "series CT" triac will commutate the full RMS current at the maximum rated junction temperature ($T_{j(max)} = 150~^{\circ}C$) without the aid of a snubber. It is used in applications where "high junction operating temperature capability" is required.

2. Features and benefits

- · 3Q technology for improved noise immunity
- 2500 V RMS isolation voltage capability
- · High commutation capability with maximum false trigger immunity
- High immunity to false turn-on by dV/dt
- High junction operating temperature capability
- · High voltage capability
- · High current capability
- · Least sensitive gate for highest noise immunity
- · Internally insulated package
- · Internally isolated mounting base
- Planar passivated for voltage ruggedness and reliability
- · Triggering in three quadrants only
- UL1557 certified (Document number E346397)

3. Applications

- Applications subject to high temperature
- Heating controls
- · High power motor control
- High power switching

4. Quick reference data

Table 1. Quick reference data

| able 1. Q | UICK reference data | | | | | |
|---------------------|--|---|-----|-----|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| Absolute | maximum rating | | | | | |
| V_{DRM} | repetitive peak off-state voltage | | - | - | 800 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; $T_{mb} \le 104 ^{\circ}\text{C}$; Fig. 1; Fig. 2; Fig. 3 | - | - | 25 | А |
| I _{TSM} | non-repetitive peak on- state current | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 20 ms; Fig. 4; Fig. 5 | - | - | 250 | А |
| | | full sine wave; $T_{j(init)} = 25 ^{\circ}C$; $t_p = 16.7 \text{ms}$ | - | - | 275 | Α |
| T _j | junction temperature | | - | - | 150 | °C |
| Static ch | aracteristics | | | _ | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; } Fig. 7$ | - | - | 35 | mA |
| | | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G-;$ $T_j = 25 \text{ °C}; Fig. 7$ | - | - | 35 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; T2- G-;}$ $T_i = 25 \text{ °C; } Fig. 7$ | - | - | 35 | mA |

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|---|--|------|-----|-----|------|
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | | - | - | 50 | mA |
| V _T | on-state voltage | I _T = 35 A; T _j = 25 °C; <u>Fig. 10</u> | | - | 1.2 | 1.5 | V |
| Dynamic | Dynamic characteristics | | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T_j = 150 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit | | 1000 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | V_D = 400 V; T_j = 150 °C; $I_{T(RMS)}$ = 25 A; dV_{com}/dt = 20 V/ μ s; (snubberless condition); gate open circuit | | 13 | - | - | A/ms |

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------------------|--|----------------|
| 1 | T1 | main terminal 1 | mb | |
| 2 | T2 | main terminal 2 |] | T2—T1 |
| 3 | G | gate | | sym051 |
| mb | n.c. | mounting base; isolated | | |

6. Ordering information

Table 3. Ordering information

| • | | | | | | |
|---------------|---------|-----------------------|---------|---------------|---------|--------------|
| Type number | Package | Orderable part number | Packing | Small packing | Package | Package |
| | Name | | method | quantity | version | issue date |
| BTA425Y-800CT | IITO220 | BTA425Y-800CTQ | Tube | 50 | SOT78D | 07-July-2010 |

7. Marking

Table 4. Marking codes

| Type number | Marking codes |
|---------------|------------------|
| BTA425Y-800CT | BTA425Y 800CT |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|--|---|-----|-------|------------------|
| V_{DRM} | repetitive peak off-state voltage | | - | 800 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; T _{mb} ≤ 104 °C; Fig 1; Fig 2; Fig 3 | - | 25 | A |
| I _{TSM} | non-repetitive peak on- state current | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 20 ms; Fig 4; Fig 5 | - | 250 | А |
| | | full sine wave; $T_{j(init)} = 25 ^{\circ}C$; $t_p = 16.7 \text{ms}$ | - | 275 | А |
| l ² t | I ² t for fusing | t _P = 10 ms; sine-wave pulse | - | 312.5 | A ² s |
| dl _⊤ /dt | rate of rise of on-state current | I _G = 0.2 A | - | 100 | A/µs |
| I _{GM} | peak gate current | | - | 2 | А |
| P_{GM} | peak gate power | | - | 5 | W |
| P _{G(AV)} | average gate power | over any 20 ms period | - | 0.5 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| T _j | junction temperature | | - | 150 | °C |

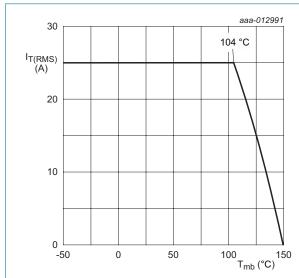


Fig. 1. RMS on-state current as a function of mounting base temperature; maximum values

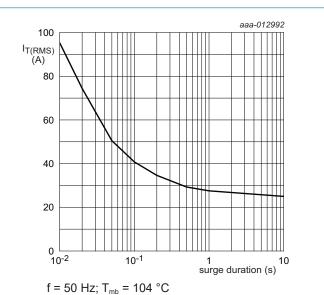
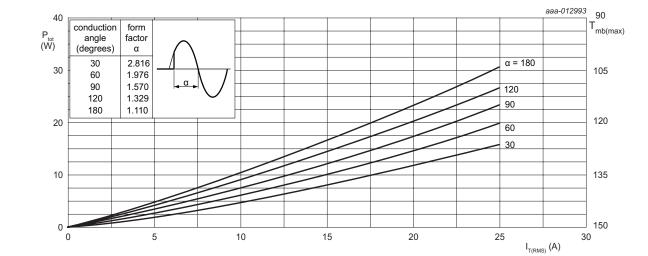


Fig. 2. RMS on-state current as a function of surge duration; maximum values

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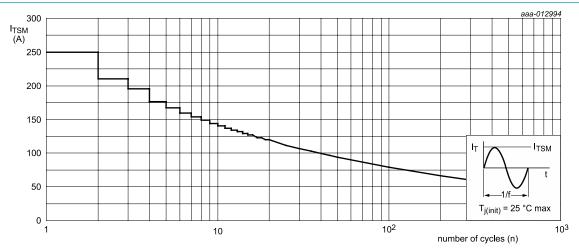
3Q Hi-Com Triac



 α = conduction angle

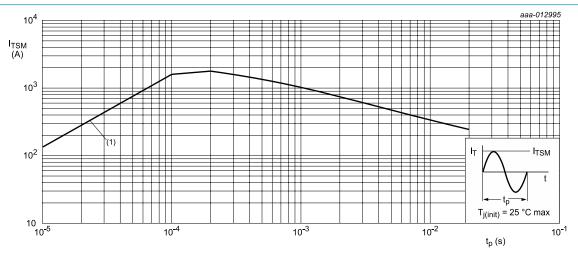
a = form factor = $I_{T(RMS)}$ / $I_{T(AV)}$

Fig. 3. Total power dissipation as a function of RMS on-state current; maximum values



f = 50 Hz

Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \le 20 \text{ ms}$

BTA425Y-800CT

(1) dI_T/dt limit

Fig. 5. Non-repetitive peak on-state current as a function of pulse duration; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---|--------------------|-----|-----|-----|------|
| R _{th(j-mb)} | thermal resistance from junction to mounting base | full cycle; Fig. 6 | - | - | 1.5 | K/W |
| $R_{\text{th(j-a)}}$ | thermal resistance from junction to ambient | in free air | - | 60 | - | K/W |

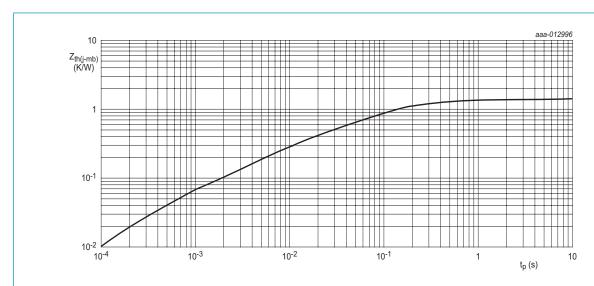


Fig. 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Isolation characteristics

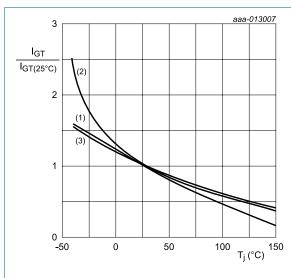
Table 7. Isolation characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|-----------------------|---|-----|-----|------|------|
| V _{isol(RMS)} | RMS isolation voltage | from all terminals to external heatsink; sinusoidal waveform; clean and dust free; 50 Hz \leq f \leq 60 Hz; RH \leq 65 %; $T_h = 25$ °C | - | - | 2500 | V |
| C _{isol} | isolation capacitance | from main terminal 2 to external heatsink; f = 1 MHz; T _h = 25 °C | - | 10 | - | pF |

11. Characteristics

Table 8. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|---|------|------|-----|------|
| Static ch | aracteristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G+; T_j = 25 °C; Fig. 7$ | - | - | 35 | mA |
| | | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ \text{ G-};$ $T_j = 25 \text{ °C}; Fig. 7$ | - | - | 35 | mA |
| | | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ T2- G-};$ $T_j = 25 \text{ °C}; \underline{\text{Fig. 7}}$ | - | - | 35 | mA |
| I _L | latching current | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{T2+ G+};$ $T_j = 25 \text{ °C}; \underline{\text{Fig. 8}}$ | - | - | 70 | mA |
| | | $V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{T2+ G-};$ $T_j = 25 \text{ °C}; \underline{\text{Fig. 8}}$ | - | - | 80 | mA |
| | | V _D = 12 V; I _G = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 8</u> | - | - | 70 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 50 | mA |
| V _T | on-state voltage | I _T = 35 A; T _j = 25 °C; <u>Fig. 10</u> | - | 1.2 | 1.5 | V |
| V_{GT} | gate trigger voltage | V _D = 12 V; T _j = 25 °C; <u>Fig. 11</u> | - | 0.9 | 1.3 | V |
| | | V _D = 400 V; T _j = 150 °C | 0.2 | 0.45 | - | V |
| I _D | off-state current | V _D = 800 V; T _j = 150 °C | - | 0.4 | 2 | mA |
| Dynamic | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T_{j} = 150 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit | 1000 | - | - | V/µs |
| dI _{com} /dt | rate of change of commutating current | V_D = 400 V; T_j = 150 °C; $I_{T(RMS)}$ = 25 A; dV_{com}/dt = 20 V/ μ s; (snubberless condition); gate open circuit | 13 | - | - | A/ms |



(1) T2- G-

(2) T2+ G-

(3) T2+ G+

Fig. 7. Normalized gate trigger current as a function of junction temperature

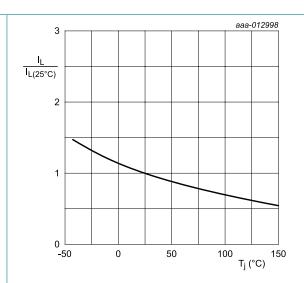


Fig. 8. Normalized latching current as a function of junction temperature

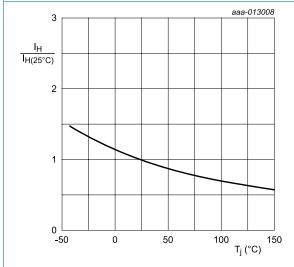
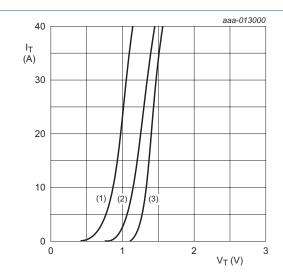


Fig. 9. Normalized holding current as a function of junction temperature



 V_o = 1.072 V; R_s = 0.010 Ω

(1) $T_j = 150$ °C; typical values (2) $T_j = 150$ °C; maximum values (3) $T_j = 25$ °C; maximum values

Fig. 10. On-state current as a function of on-state voltage

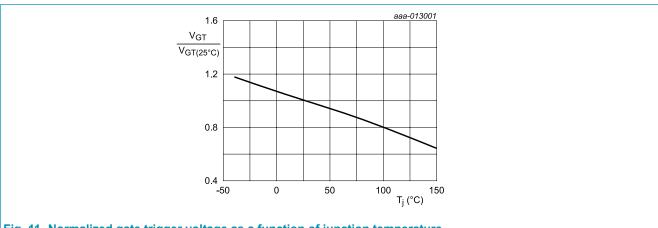
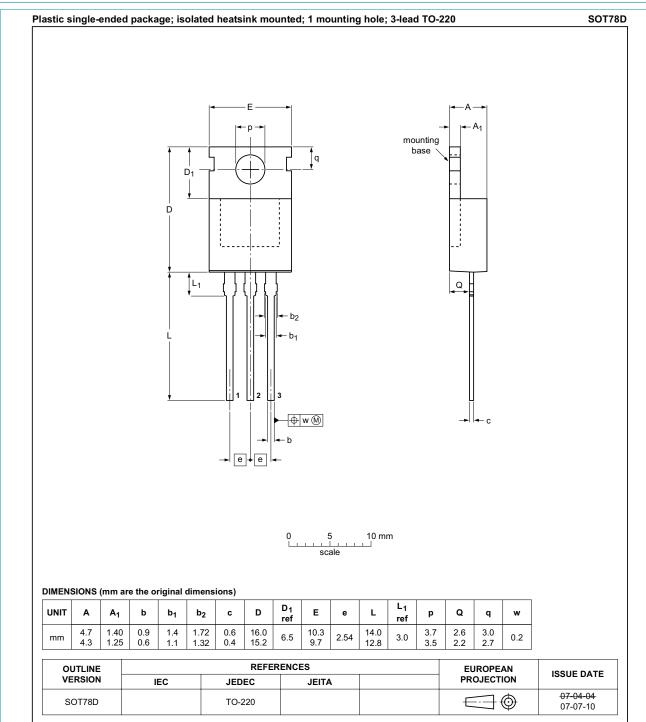


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

12. Package outline



13. Legal information

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| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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